

Novel Nano and Molecular Electronics

Description:

The technology allows users to obtain electrical measurements of small devices and minute amounts of materials. These devices could include magnetoelectronic/spintronic devices and high-impedance devices, for instance a metallic single-walled carbon-nanotube (mSWNT), a SWNT transistor, a minimum-size deep-submicron metal-oxide semiconductor (MOS) field-effect-transistor (FET), a sub-micron MOS FET that is operating in sub-threshold region, and a molecular device. Other materials of measurement interest may include on-chip biofluids, chemicals, and thin films.

Applications

- Micro/Nano electronics characterization
- Biosensing applications
- Diagnostic devices

Benefits

- Increased measurement precision capability
- Potential earlier detection
- Less material needed for measurement

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Protection Status:	Patent issued; # 7,724,005
Licensing Status:	Available for licensing
Additional Terms:	Micro-electronics, Nano-electronics, Biosensing, Diagnostic, Carbon nanotubes
CURF Ref No:	07-036

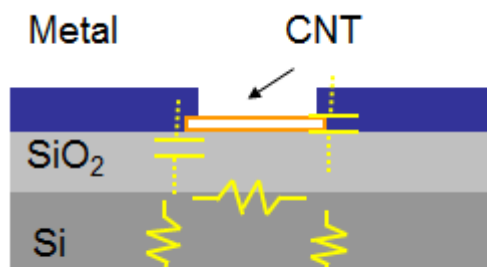


Figure 1: Cross section of cNT microwave characterization set-up.